

Notice of References Cited	Application/Control No. 10/814,141	Applicant(s)/Patent Under Reexamination CHO ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0219920	11-2003	Baek et al.	438/30
*	B	US-2004/0121614	06-2004	Baek et al.	438/743
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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